

<b>Search Notes</b> 	<b>Application/Control No.</b> 10/606,117	<b>Applicant(s)/Patent under Reexamination</b> CHOW, ALAN Y.
	<b>Examiner</b> Frances P. Oropeza	<b>Art Unit</b> 3766

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner